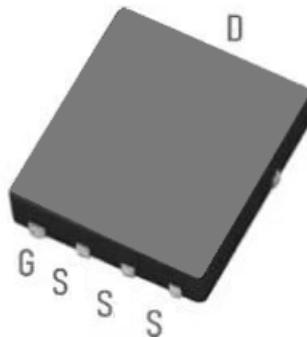


Description

Silicon Carbide (SiC) MOSFET use a completely new technology that provide superior switching performance and higher reliability compared to Silicon. In addition, the low ON resistance and compact chip size ensure low capacitance and gate charge. Consequently, system benefits include highest efficiency, faster operating frequency, increased power density, reduced EMI, and reduced system size.

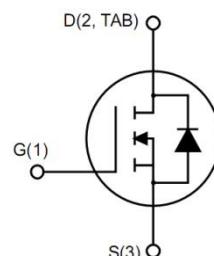
Features

- High Speed Switching with Low Capacitances
- High Blocking Voltage with Low RDS(on)
- Optimized package with separate driver source pin
- Easy to parallel and simple to drive
- ROHS Compliant, Halogen free



Application

- EV Charging
- DC/DC Converters
- Switch Mode Power Supplies
- Power Factor Correction Modules
- Solar PV inverters



Ordering Information

Part Number	Marking	Package	Packaging
ASR320N650D88	ASR320N650D88	DFN8*8	Reel

Absolute Maximum Ratings(Tc=25°C)

Symbol	Parameter	Value	Unit
V _{DS}	Drain-Source Voltage	650	V
I _D	Drain Current(continuous)at Tc=25°C	8	A
I _D	Drain Current(continuous)at Tc=100°C	6	A
I _{DM}	Drain Current (pulsed)	12	A
V _{GS}	Gate-Source Voltage	-5/+15	V
P _D	Power Dissipation Tc = 25°C	65	W
T _J , T _{tsg}	Junction and Storage Temperature Range	-55 to +150	°C

Electrical Characteristics(T_J = 25°C unless otherwise specified)
Typical Performance-Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
BV _{DS}	Drain-source Breakdown Voltage	I _D =250uA, V _{GS} =0V	650			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =650V, V _{GS} =0V, T _J =25°C			50	μ A
I _{GSS}	Gate-body Leakage Current	V _{DS} =0 V ; V _{GS} =-5 to 15V		10	250	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D =1mA	1.5	1.9	2.5	V
V _{GS(on)}	Recommended turn-on Voltage	Static		12		V
V _{GS(off)}	Recommended turn-off Voltage			-3		V
R _{DS(on)}	Static Drain-source On Resistance	V _{GS} =12V, I _D =2A		320	380	mΩ
		V _{GS} =12V, I _D =2A T _J =150°C		500		mΩ

Typical Performance-Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C_{iss}	Input Capacitance	$V_{DS}=600V, f=1MHz,$ $V_{AC}=25mV$		339		pF
C_{oss}	Output Capacitance			20		pF
C_{rss}	Reverse Transfer Capacitance			3.5		pF
g_{fs}	Transconductance	$V_{DS}=12V, I_D=2A$		2.8		S
E_{OSS}	Coss Stored Energy	$V_{DS}=600V, f=1MHz$		5		μJ
E_{ON}	Turn-On Energy (Body Diode)	$V_{DS}=400V, V_{GS}=-3/12V,$ $I_D=2A, L=1.5mH$ $T_J=150^{\circ}C$		47		μJ
E_{OFF}	Turn-Off Energy (Body Diode)			8.5		μJ
Q_g	Total Gate Charge	$V_{DS}=400V, V_{GS}=-3V/12V,$ $I_D = 2 A$		12.8		nC
Q_{gs}	Gate-source Charge			3		nC
Q_{gd}	Gate-Drain Charge			4		nC
$R_{G(int)}$	Internal Gate Resistance	$f=1MHz, V_{AC}=25mV$		8		Ω
$t_{d(on)}$	Turn-on Delay Time	$V_{DS}=400V, V_{GS}=-3V/12V,$ $I_D = 2A, L=1mH$ $R_{ext}=2.5\Omega$		5		ns
t_r	Rise Time			6		ns
$t_{d(off)}$	Turn-off Delay Time			7		ns
t_f	Fall Time			8.8		ns

Typical Performance-Reverse Diode($T_J = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_{FSD}	Forward Voltage	$V_{GS}=0V, I_F=2A, T_J=25^{\circ}C$		5.5	6.5	V
		$V_{GS}=0V, I_F=2A, T_J=150^{\circ}C$		4.8	6.5	V
I_s	Continuous Diode Forward Current	$V_{GS}=0V, T_C=25^{\circ}C$				A
t_{rr}	Reverse Recovery Time	$V_{GS}=-3 V, I_F=2 A,$ $V_R=400 V, T_J=150^{\circ}C$ $dI/dt= 1000 A/\mu s$				nS
Q_{rr}	Reverse Recovery Charge					nC
I_{rrm}	Peak Reverse Recovery Current					A

Thermal Characteristics

Symbol	Parameter	Value.	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.92	$^{\circ}C/W$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	62	$^{\circ}C/W$

The values are based on the junction-to case thermal impedance which is measured with the device mounted to a large heat sink assuming maximum junction temperature of $T_J(max)=150^{\circ}C$

Electrical Characteristics

Fig1. Output characteristics ($T_J = 25^\circ\text{C}$)

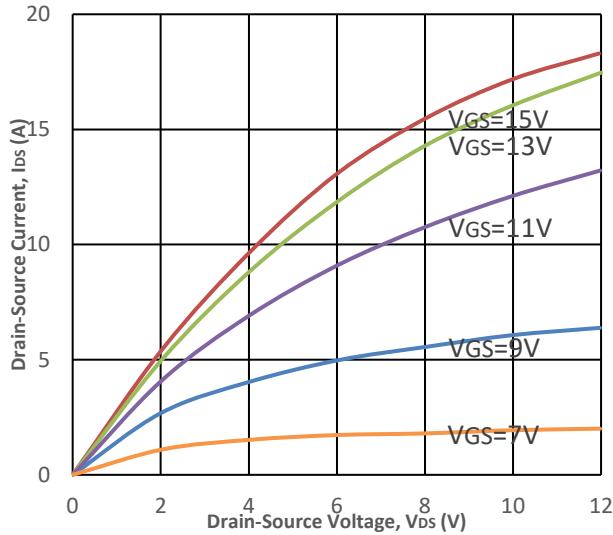


Fig2. Output characteristics ($T_J = 150^\circ\text{C}$)

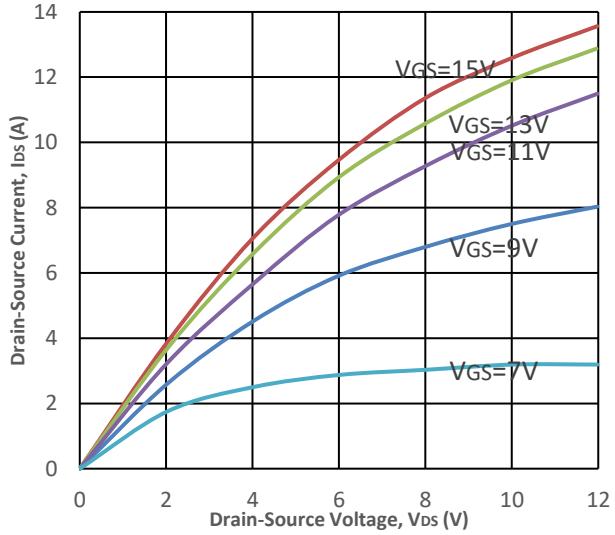


Fig3. Normalized On-Resistance vs. Temperature

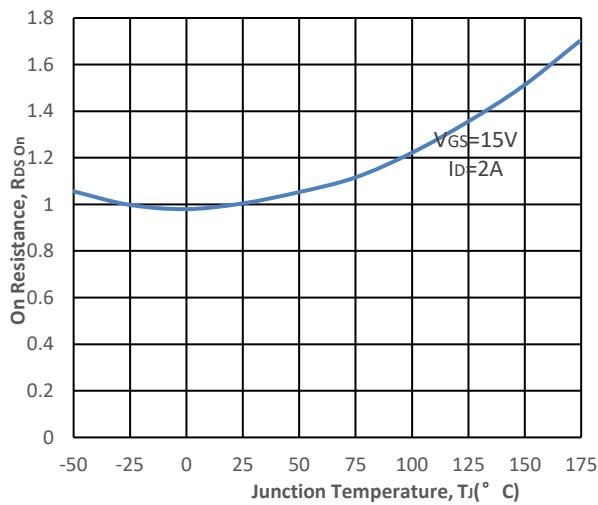


Fig4. On-Resistance vs. Temperature

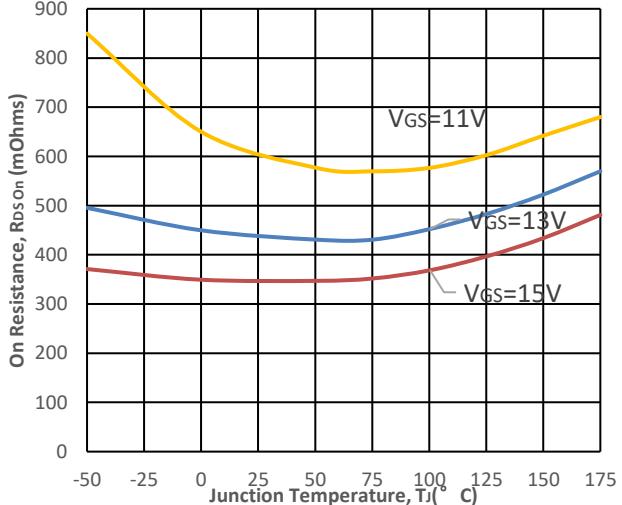


Fig5. Transfer Characteristic

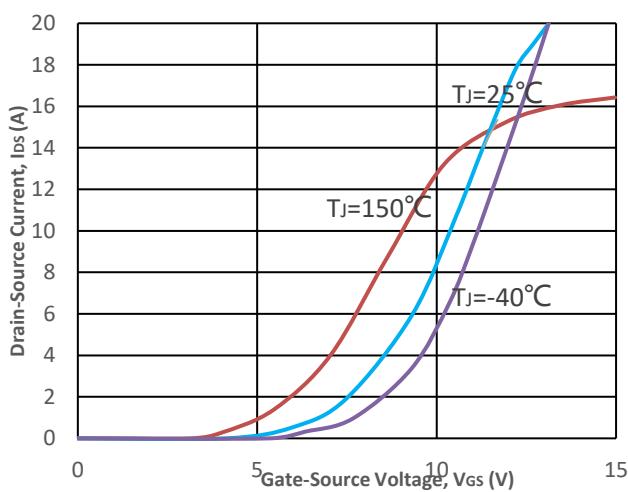


Fig6. Body Diode Characteristic at 25°C

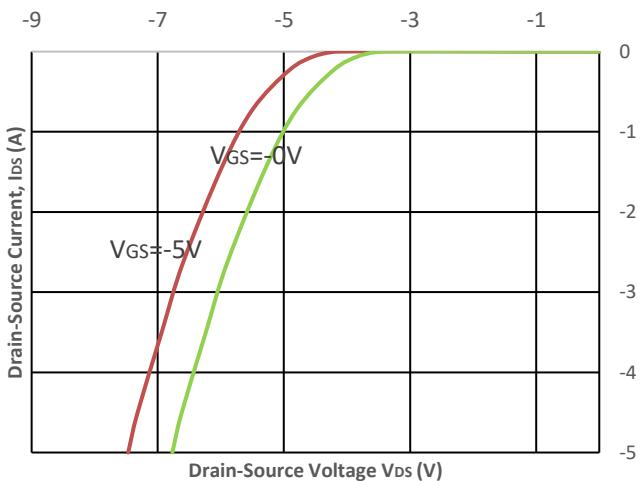


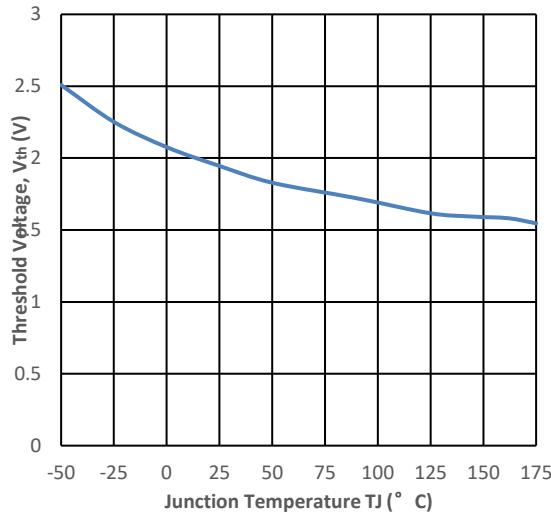
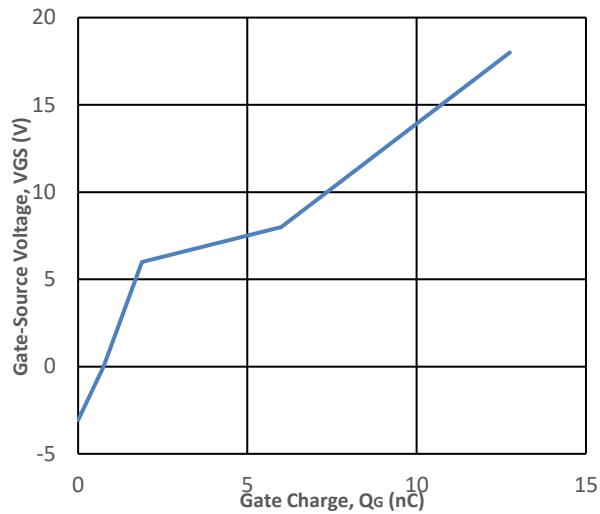
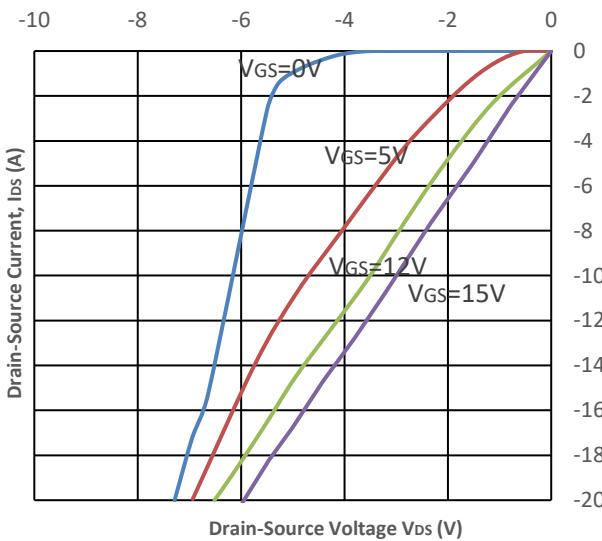
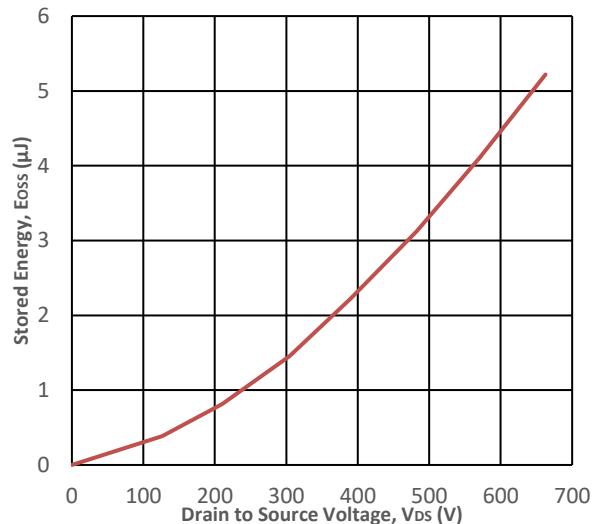
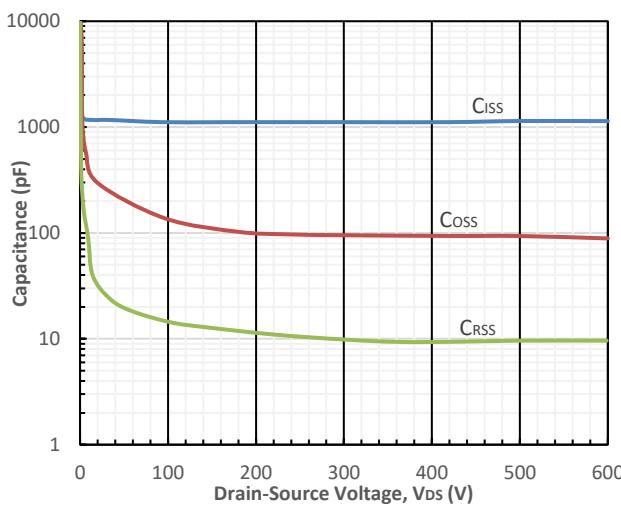
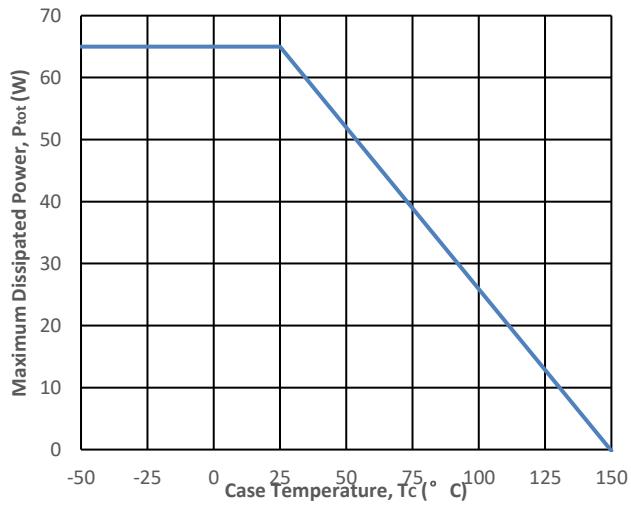
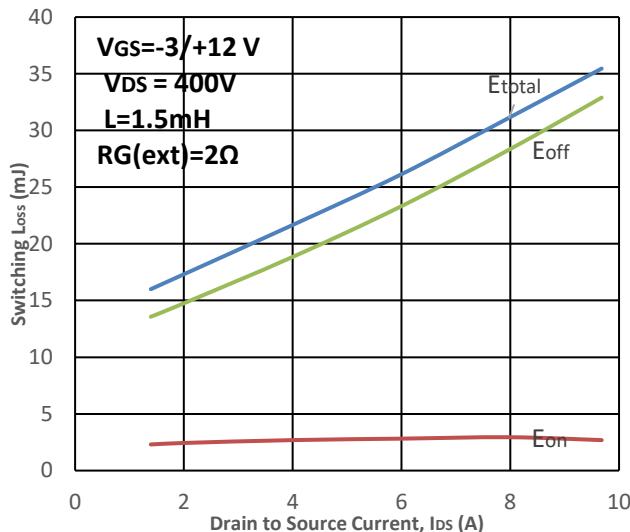
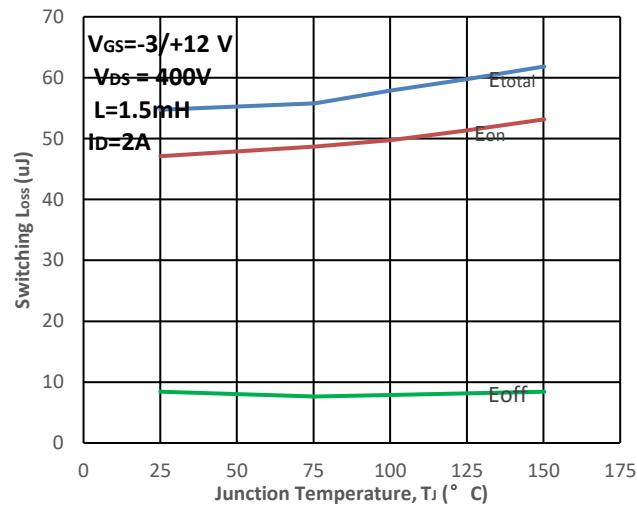
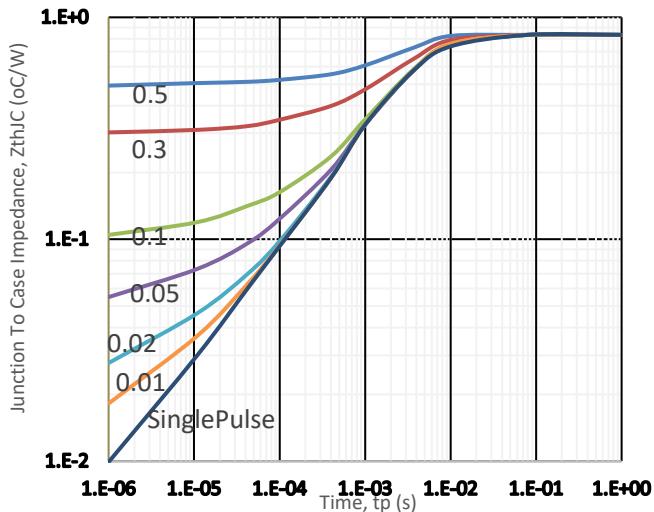
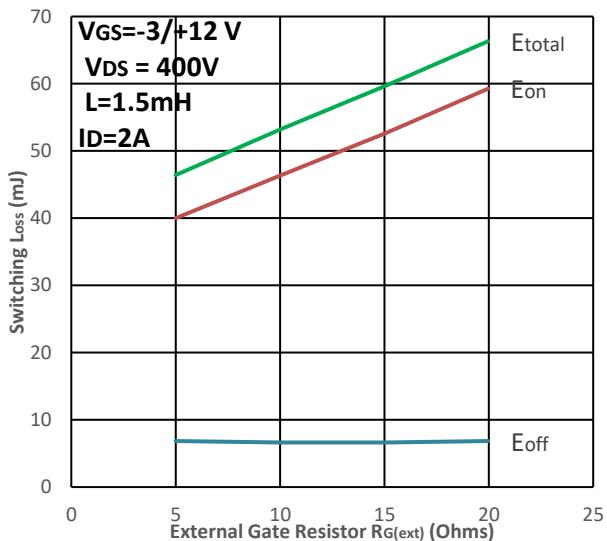
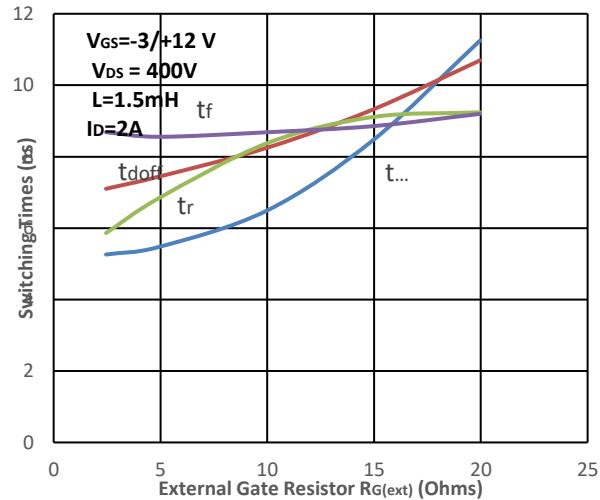
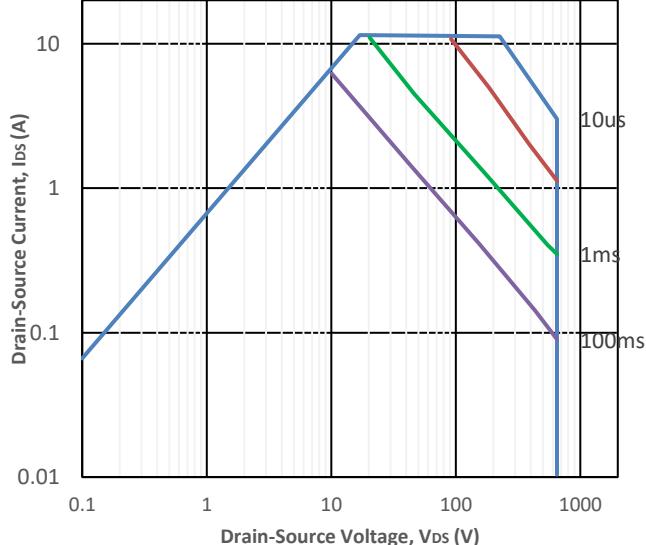
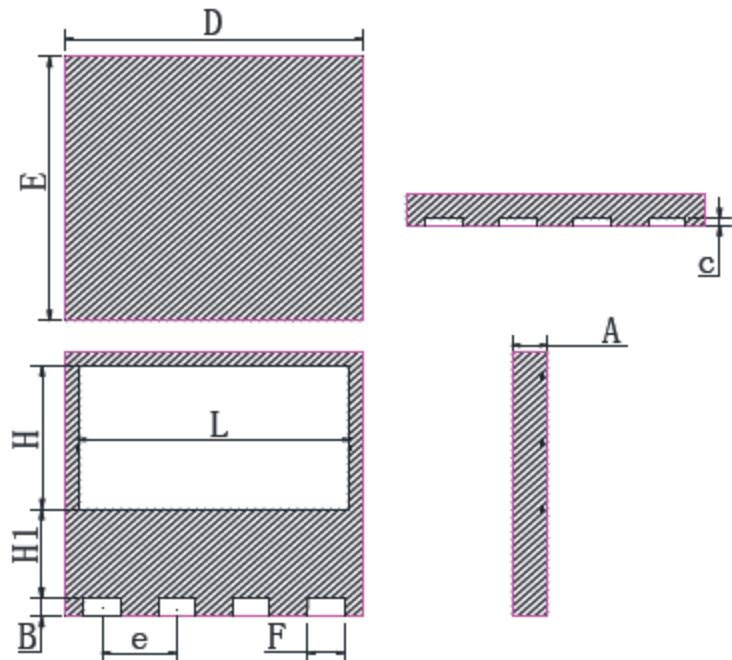
Fig7.Threshold Voltage vs. Temperature

Fig8. Gate Charge Characteristics

Fig9. 3rd Quadrant Characteristic at 25 °C

Fig10. Output Capacitor Stored Energy

Fig11. Capacitances vs. Drain-Source

Fig12. Max Power Dissipation Derating Vs Tc


Fig13. Switching Energy vs. Drain Current

Fig15. Switching Energy vs. Temperature

Fig17. Transient Thermal Impedance

Fig14. Switching Energy vs. RG(ext)

Fig16. Switching Times vs. RG(ext)

Fig18. Safe Operating Area


Package Drawing:**Dimensions (UNIT: mm)**

Symbol	Min	Typ	Max
A	0.90	0.95	1.00
B	0.45	0.55	0.65
C	0.153	0.203	0.253
D	7.90	8.00	8.10
E	7.90	8.00	8.10
e	1.90	2.00	2.10
F	0.90	1.00	1.10
H	4.20	4.35	4.45
H1	2.60	2.70	2.80
L	7.10	7.20	7.3